

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No.: RZA2009-1263FCC

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ANNEX D: Probe Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TA Shanghai (Auden)**

Certificate No: **ET3-1737_Nov08**

CALIBRATION CERTIFICATE

Object **ET3DV6 - SN:1737**

Calibration procedure(s) **QA CAL-01.v6, QA CAL-12.v5 and QA CAL-23.v3
Calibration procedure for dosimetric E-field probes**

Calibration date: **November 25, 2008**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|----------------------------|-----------------|-------------------------------|-----------------------|
| Power meter E4419B | GB41293874 | 1-Apr-08 (No. 217-00788) | Apr-09 |
| Power sensor E4412A | MY41495277 | 1-Apr-08 (No. 217-00788) | Apr-09 |
| Power sensor E4412A | MY41498087 | 1-Apr-08 (No. 217-00788) | Apr-09 |
| Reference 3 dB Attenuator | SN: S5054 (3c) | 1-Jul-08 (No. 217-00865) | Jul-09 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-08 (No. 217-00787) | Apr-09 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 1-Jul-08 (No. 217-00866) | Jul-09 |
| Reference Probe ES3DV2 | SN: 3013 | 2-Jan-08 (No. ES3-3013_Jan08) | Jan-09 |
| DAE4 | SN: 660 | 9-Sep-08 (No. DAE4-660_Sep08) | Sep-09 |

| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
|---------------------------|--------------|-----------------------------------|------------------------|
| RF generator HP 8648C | US3642U01700 | 4-Aug-99 (in house check Oct-07) | In house check: Oct-09 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-08) | In house check: Oct-09 |

| | | | |
|----------------|------------------------------|--------------------------------------|---------------|
| Calibrated by: | Name Katja Pokovic | Function Technical Manager | Signature |
| Approved by: | Name Niels Kuster | Function Quality Manager | Signature |

Issued: November 25, 2008

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Accreditation No.: SCS 108

Glossary:

| | |
|--------------------------|--|
| TSL | tissue simulating liquid |
| NORM _{x,y,z} | sensitivity in free space |
| ConvF | sensitivity in TSL / NORM _{x,y,z} |
| DCP | diode compression point |
| Polarization ϕ | ϕ rotation around probe axis |
| Polarization ϑ | ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis |

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E²-field uncertainty inside TSL (see below *ConvF*).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

ET3DV6 SN:1737

November 25, 2008

Probe ET3DV6

SN:1737

| | |
|------------------|--------------------|
| Manufactured: | September 27, 2002 |
| Last calibrated: | February 19, 2007 |
| Repaired: | November 18, 2008 |
| Recalibrated: | November 25, 2008 |

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

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ET3DV6 SN:1737

November 25, 2008

DASY - Parameters of Probe: ET3DV6 SN:1737

Sensitivity in Free Space^A

Diode Compression^B

| | | | | |
|-------|--------------|-------------------------------------|-------|-------|
| NormX | 1.42 ± 10.1% | $\mu\text{V}/(\text{V}/\text{m})^2$ | DCP X | 93 mV |
| NormY | 1.68 ± 10.1% | $\mu\text{V}/(\text{V}/\text{m})^2$ | DCP Y | 94 mV |
| NormZ | 1.63 ± 10.1% | $\mu\text{V}/(\text{V}/\text{m})^2$ | DCP Z | 85 mV |

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz Typical SAR gradient: 5 % per mm

| | | | |
|---|------------------------------|--------|--------|
| Sensor Center to Phantom Surface Distance | | 3.7 mm | 4.7 mm |
| SAR _{be} [%] | Without Correction Algorithm | 10.7 | 6.9 |
| SAR _{be} [%] | With Correction Algorithm | 0.3 | 0.4 |

TSL 1750 MHz Typical SAR gradient: 10 % per mm

| | | | |
|---|------------------------------|--------|--------|
| Sensor Center to Phantom Surface Distance | | 3.7 mm | 4.7 mm |
| SAR _{be} [%] | Without Correction Algorithm | 12.5 | 8.4 |
| SAR _{be} [%] | With Correction Algorithm | 0.8 | 0.5 |

Sensor Offset

Probe Tip to Sensor Center 2.7 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

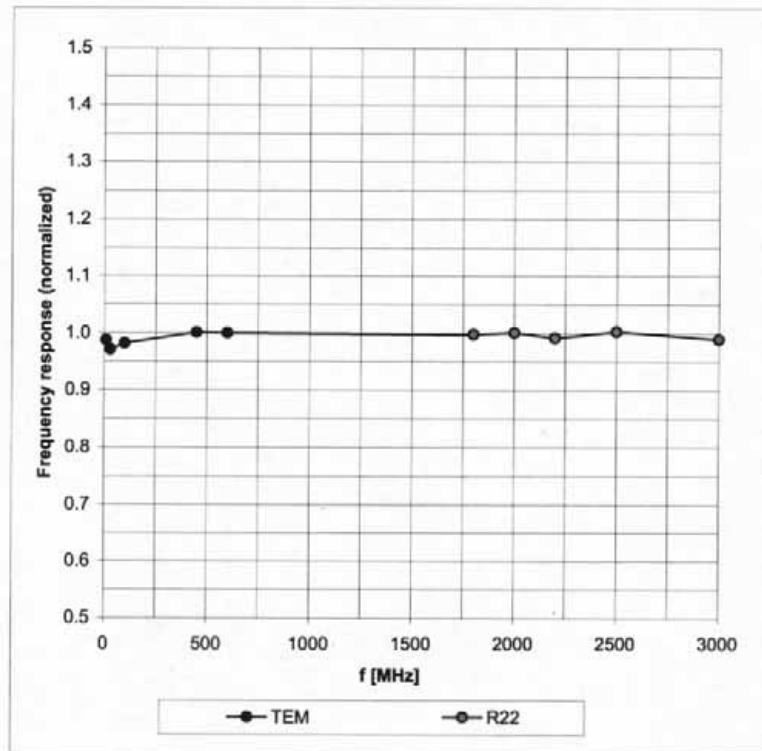
^B Numerical linearization parameter; uncertainty not required.

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Frequency Response of E-Field

(TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

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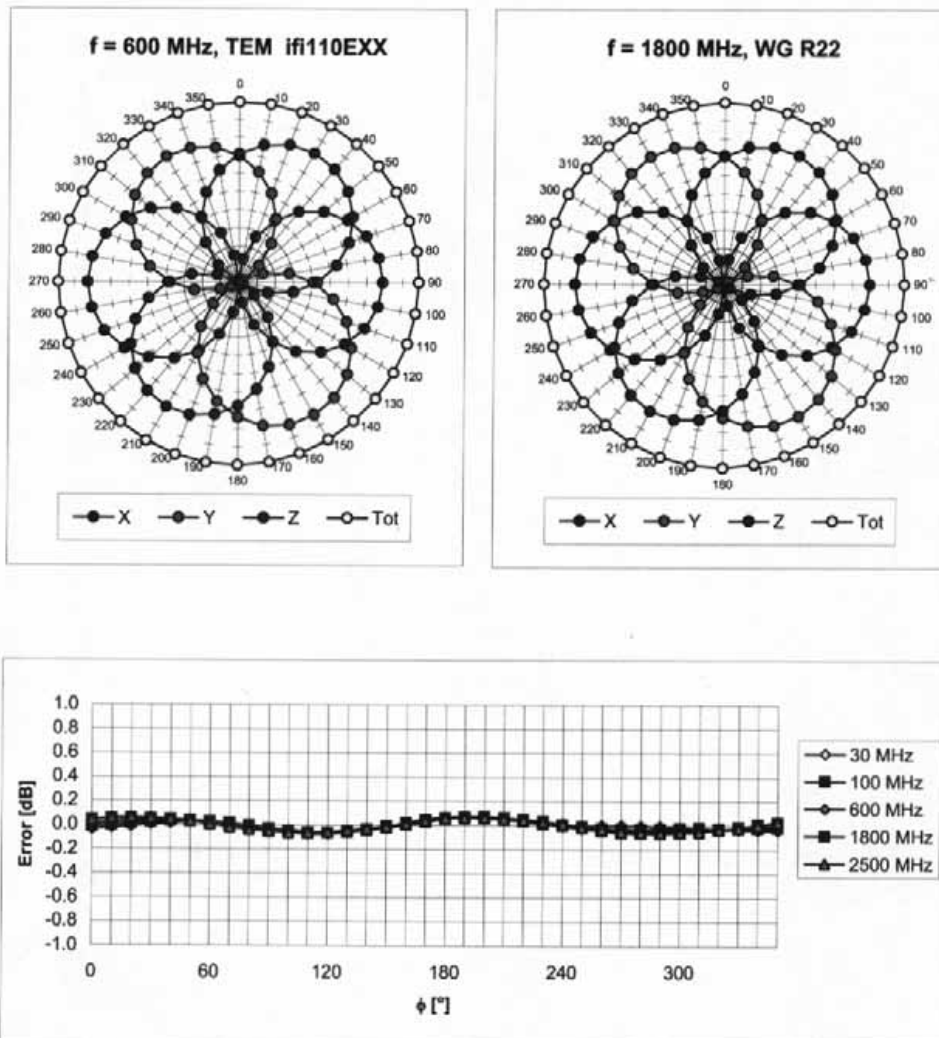
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Receiving Pattern (ϕ), $\theta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

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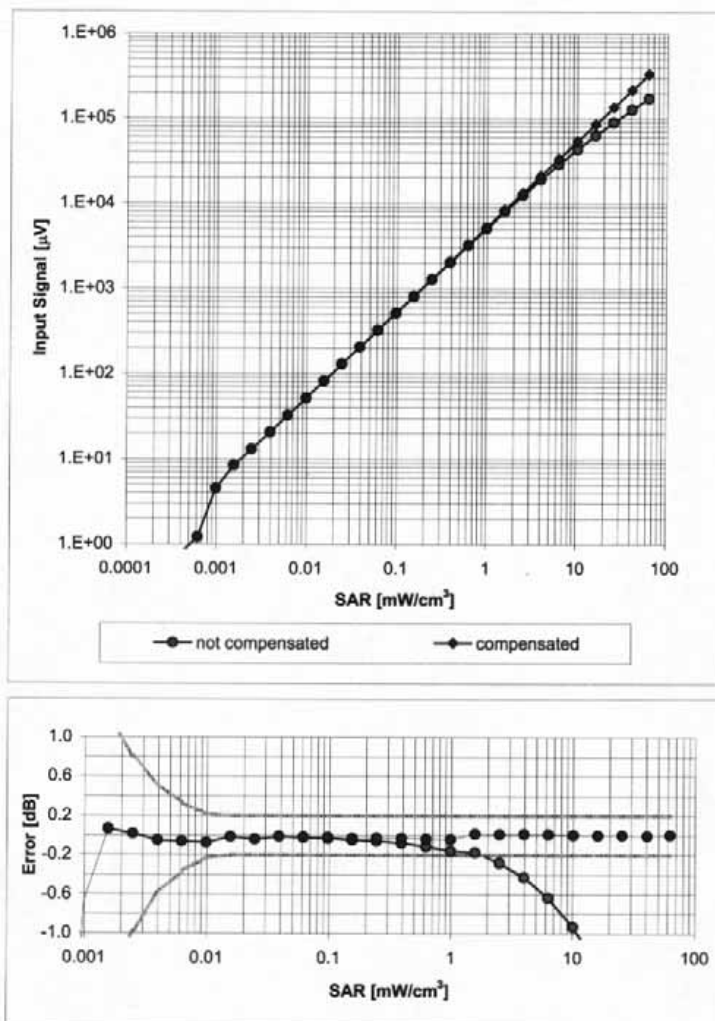
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Dynamic Range $f(\text{SAR}_{\text{head}})$
(Waveguide R22, $f = 1800 \text{ MHz}$)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

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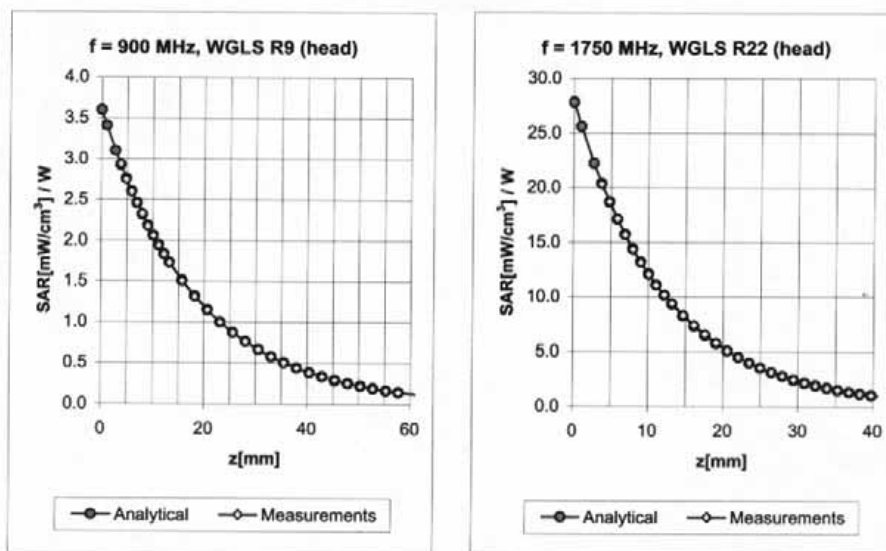
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Conversion Factor Assessment



| f [MHz] | Validity [MHz] ^c | TSL | Permittivity | Conductivity | Alpha | Depth | ConvF Uncertainty |
|---------|-----------------------------|------|--------------|--------------|-------|-------|--------------------|
| 450 | ± 50 / ± 100 | Head | 43.5 ± 5% | 0.87 ± 5% | 0.36 | 1.84 | 7.20 ± 13.3% (k=2) |
| 835 | ± 50 / ± 100 | Head | 41.5 ± 5% | 0.90 ± 5% | 0.25 | 3.53 | 6.33 ± 11.0% (k=2) |
| 900 | ± 50 / ± 100 | Head | 41.5 ± 5% | 0.97 ± 5% | 0.27 | 3.53 | 6.14 ± 11.0% (k=2) |
| 1750 | ± 50 / ± 100 | Head | 40.1 ± 5% | 1.37 ± 5% | 0.56 | 2.77 | 5.35 ± 11.0% (k=2) |
| 1950 | ± 50 / ± 100 | Head | 40.0 ± 5% | 1.40 ± 5% | 0.57 | 2.72 | 4.89 ± 11.0% (k=2) |
| 2450 | ± 50 / ± 100 | Head | 39.2 ± 5% | 1.80 ± 5% | 0.51 | 1.60 | 4.39 ± 11.0% (k=2) |
| 450 | ± 50 / ± 100 | Body | 56.7 ± 5% | 0.94 ± 5% | 0.27 | 1.80 | 7.52 ± 13.3% (k=2) |
| 835 | ± 50 / ± 100 | Body | 55.2 ± 5% | 0.97 ± 5% | 0.36 | 2.75 | 6.14 ± 11.0% (k=2) |
| 900 | ± 50 / ± 100 | Body | 55.0 ± 5% | 1.05 ± 5% | 0.43 | 2.51 | 5.98 ± 11.0% (k=2) |
| 1750 | ± 50 / ± 100 | Body | 53.4 ± 5% | 1.49 ± 5% | 0.99 | 1.74 | 4.84 ± 11.0% (k=2) |
| 1950 | ± 50 / ± 100 | Body | 53.3 ± 5% | 1.52 ± 5% | 0.99 | 1.50 | 4.60 ± 11.0% (k=2) |
| 2450 | ± 50 / ± 100 | Body | 52.7 ± 5% | 1.95 ± 5% | 0.98 | 1.42 | 3.91 ± 11.0% (k=2) |

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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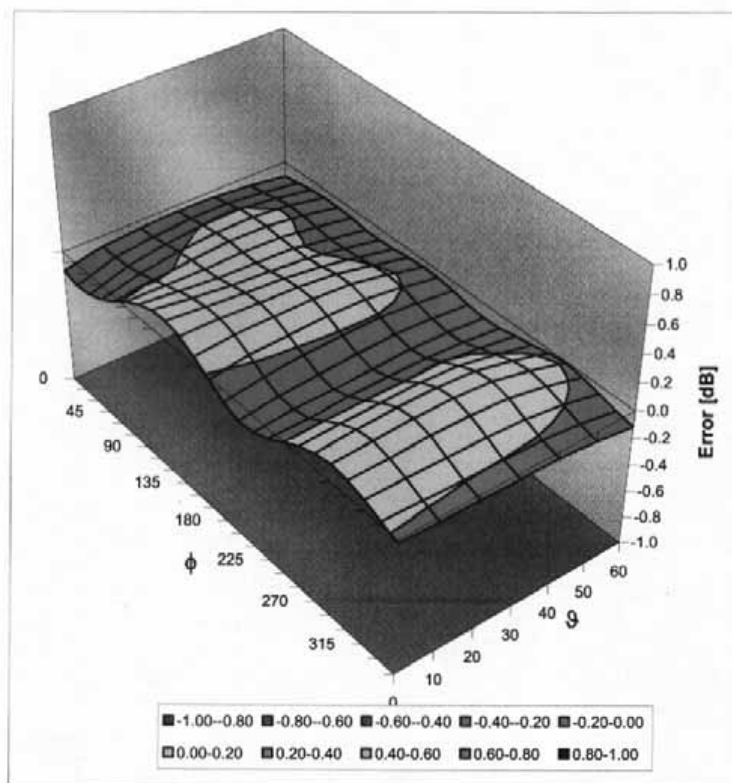
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Deviation from Isotropy in HSL

Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

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ANNEX E: D835V2 Dipole Calibration Certificate

信息产业部通信计量中心
Telecommunication Metrology Center of MII

TMC

ILAC-MRA

CNAS 检测
CNAS L0442

Client: TA Certificate No: D835V2-4d020_Jul09

CALIBRATION CERTIFICATE

Object: D835V2 - SN: 4d020

Calibration Procedure(s): TMC-XZ-01-027
Calibration procedure for dipole validation kits

Calibration date: July 15, 2009

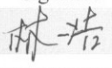
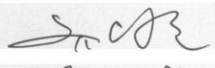
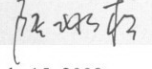
Condition of the calibrated item: In Tolerance

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)℃ and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date(Calibrated by, Certificate No.) | Scheduled Calibration |
|------------------------|------------|--|-----------------------|
| Power Meter NRVD | 101253 | 19-Jun-09 (TMC, No.JZ09-248) | Jun-10 |
| Power sensor NRV-Z5 | 100333 | 19-Jun-09 (TMC, No. JZ09-248) | Jun-10 |
| Reference Probe ES3DV3 | SN 3149 | 08-Dec-08(SPEAG, No.ES3-3149_Dec08) | Dec-09 |
| DAE4 | SN 771 | 21-Nov-08(SPEAG, No.DAE4-771_Nov08) | Nov-09 |
| RF generator E4438C | MY45092879 | 18-Jun-09(TMC, No.JZ09-302) | Jun-10 |
| Network Analyzer 8753E | US38433212 | 03-Aug-08(TMC, No.JZ08-056) | Aug-09 |

| | Name | Function | Signature |
|----------------|-------------|-----------------------------------|---|
| Calibrated by: | Lin Hao | SAR Test Engineer |  |
| Reviewed by: | Qi Dianyuan | SAR Project Leader |  |
| Approved by: | Lu Bingsong | Deputy Director of the laboratory |  |

Issued: July 15, 2009

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Certificate No: D835V2-4d020_Jul09

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Glossary:

| | |
|-------|--|
| TSL | tissue simulating liquid |
| ConvF | sensitivity in TSL / NORM _{x,y,z} |
| N/A | not applicable or not measured |

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

| | | |
|-------------------------------------|------------------------|-------------|
| DASY Version | DASY5 | V5.0 |
| Extrapolation | Advanced Extrapolation | |
| Phantom | 2mm Oval Phantom ELI4 | |
| Distance Dipole Center - TSL | 15 mm | with Spacer |
| Zoom Scan Resolution | dx, dy, dz = 5 mm | |
| Frequency | 835 MHz \pm 1 MHz | |

Head TSL parameters

The following parameters and calculations were applied.

| | Temperature | Permittivity | Conductivity |
|---|---------------------|----------------|----------------------|
| Nominal Head TSL parameters | 22.0 °C | 41.5 | 0.90 mho/m |
| Measured Head TSL parameters | (22.0 \pm 0.2) °C | 41.2 \pm 6 % | 0.91 mho/m \pm 6 % |
| Head TSL temperature during test | (21.7 \pm 0.2) °C | ---- | ---- |

SAR result with Head TSL

| SAR averaged over 1 cm^3 (1 g) of Head TSL | Condition | |
|--|--------------------|---|
| SAR measured | 250 mW input power | 2.40 mW / g |
| SAR normalized | normalized to 1W | 9.60 mW / g |
| SAR for nominal Head TSL parameters ¹ | normalized to 1W | 9.2 mW / g \pm 17.0 % (k=2) |

| SAR averaged over 10 cm^3 (10 g) of Head TSL | Condition | |
|--|--------------------|--|
| SAR measured | 250 mW input power | 1.55 mW / g |
| SAR normalized | normalized to 1W | 6.20 mW / g |
| SAR for nominal Head TSL parameters ¹ | normalized to 1W | 6.07 mW / g \pm 16.5 % (k=2) |

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Body TSL parameters

The following parameters and calculations were applied.

| | Temperature | Permittivity | Conductivity |
|----------------------------------|-----------------|--------------|-----------------|
| Nominal Body TSL parameters | 22.0 °C | 55.2 | 0.97 mho/m |
| Measured Body TSL parameters | (22.0 ± 0.2) °C | 54.6 ± 6% | 0.99mho/m ± 6 % |
| Body TSL temperature during test | (21.9 ± 0.2) °C | ---- | ---- |

SAR result with Body TSL

| SAR averaged over 1 cm^3 (1 g) of Body TSL | Condition | |
|--|--------------------|-----------------------------------|
| SAR measured | 250 mW input power | 2.41 mW / g |
| SAR normalized | normalized to 1W | 9.64 mW / g |
| SAR for nominal Body TSL parameters ² | normalized to 1W | 9.28 mW / g ± 17.0 % (k=2) |

| SAR averaged over 10 cm^3 (10 g) of Body TSL | Condition | |
|--|--------------------|-----------------------------------|
| SAR measured | 250 mW input power | 1.58 mW / g |
| SAR normalized | normalized to 1W | 6.32 mW / g |
| SAR for nominal Body TSL parameters ² | normalized to 1W | 6.19 mW / g ± 16.5 % (k=2) |

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Appendix

Antenna Parameters with Head TSL

| | |
|--------------------------------------|---------------|
| Impedance, transformed to feed point | 53.7Ω -3.7 jΩ |
| Return Loss | - 25.9dB |

Antenna Parameters with Body TSL

| | |
|--------------------------------------|----------------|
| Impedance, transformed to feed point | 49.4Ω - 5.1 jΩ |
| Return Loss | -25.6dB |

General Antenna Parameters and Design

| | |
|----------------------------------|----------|
| Electrical Delay (one direction) | 1.387 ns |
|----------------------------------|----------|

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

| | |
|-----------------|----------------|
| Manufactured by | SPEAG |
| Manufactured on | April 22, 2004 |

DASY5 Validation Report for Head TSL

Certificate No: D835V2-4d020_Jul09

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Date/Time: 2009-7-15 14:54:13

Test Laboratory: TMC, Beijing, China

DUT: Dipole 835 MHz; Type: D835V2; Serial: SN: 4d020

Communication System: CW Frequency: 835 MHz Duty Cycle: 1:1

Medium: Head 835MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.91 \text{ mho/m}$; $\epsilon_r = 41.2$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(6.34, 6.34, 6.34); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=15mm/Zoom Scan (7x7x7)/Cube 0:

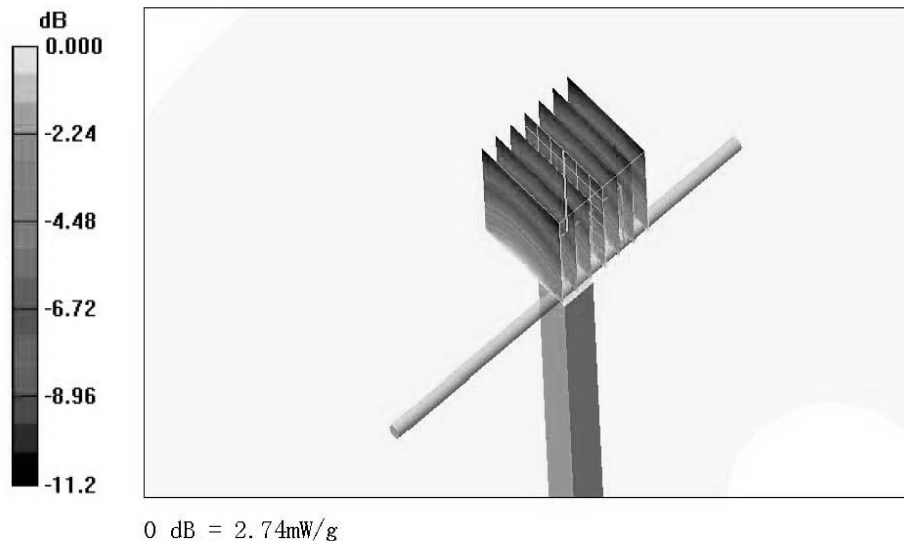
Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$

Reference Value = 55.2 V/m; Power Drift = -0.019 dB

Peak SAR (extrapolated) = 3.16 W/kg

SAR(1 g) = 2.4 mW/g; SAR(10 g) = 1.55 mW/g

Maximum value of SAR (measured) = 2.74 mW/g



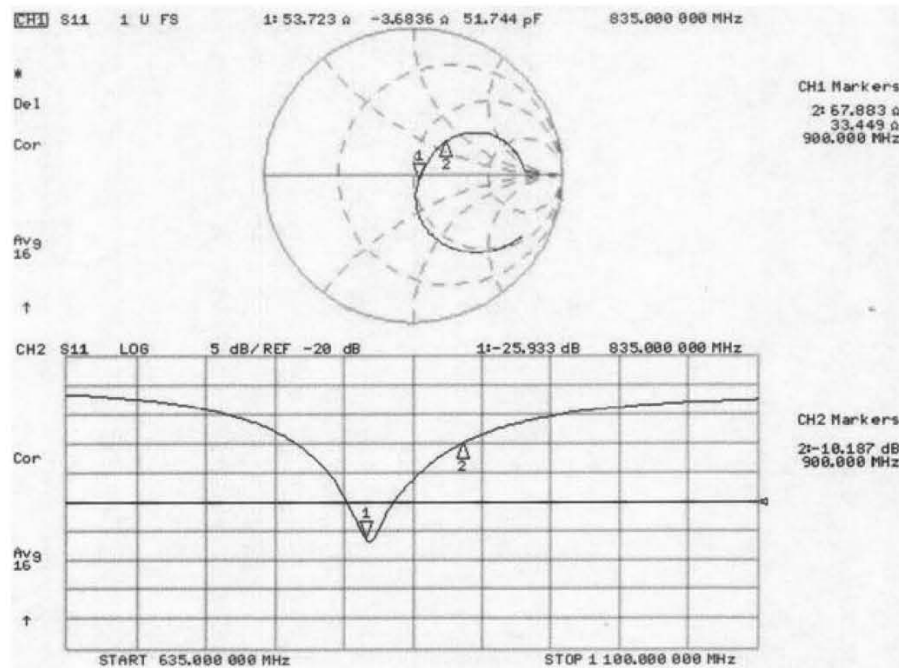
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Impedance Measurement Plot for Head TSL



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DASY5 Validation Report for Body TSL

Date/Time: 2009-7-15 11:27:23

Test Laboratory: TMC, Beijing, China

DUT: Dipole 835 MHz; Type: D835V2; Serial: SN: 4d020

Communication System: CW Frequency: 835 MHz Duty Cycle: 1:1

Medium: Body 835MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.99 \text{ mho/m}$; $\epsilon_r = 54.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(6.02, 6.02, 6.02); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=15mm/Zoom Scan (7x7x7)/Cube 0:

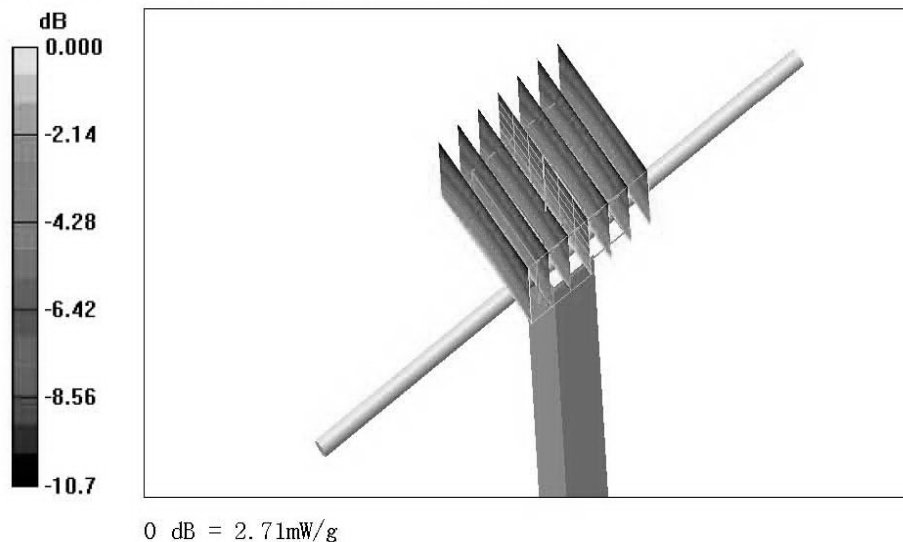
Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$

Reference Value = 54.1 V/m ; Power Drift = -0.004 dB

Peak SAR (extrapolated) = 3.81 W/kg

SAR(1 g) = 2.41 mW/g ; SAR(10 g) = 1.58 mW/g

Maximum value of SAR (measured) = 2.71 mW/g



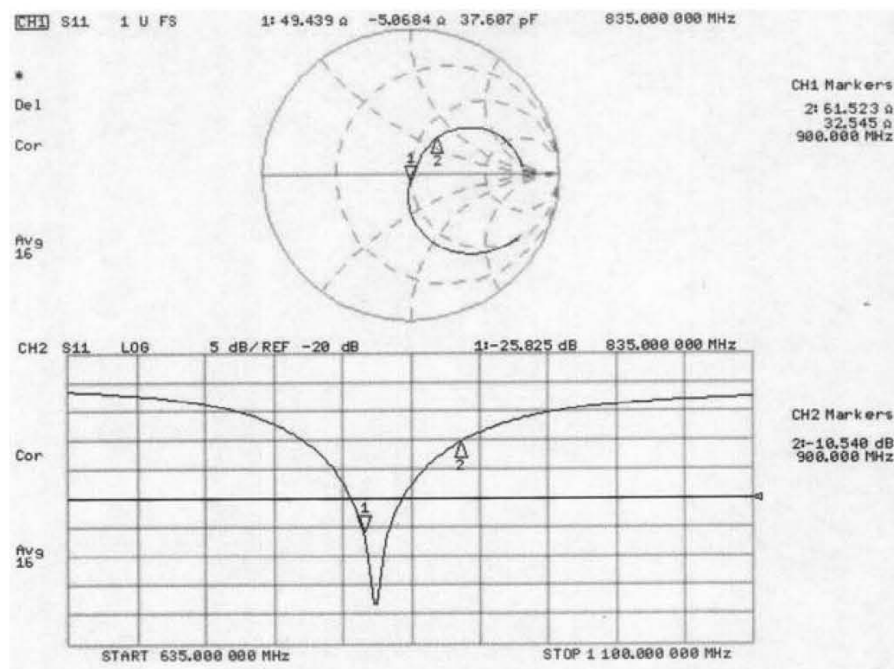
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Impedance Measurement Plot for Body TSL



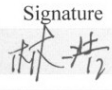
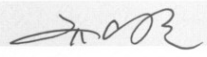
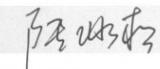
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ANNEX F: D1900V2 Dipole Calibration Certificate

| | | | | |
|---|---|--|--|--------------------------|
| 信息产业部通信计量中心 Telecommunication Metrology Center of MII | | TMC | ILAC-MRA | CNAS 检测 CNAS L0442 |
| Client | TA | Certificate No: D1900V2-5d060_Jul09 | | |
| CALIBRATION CERTIFICATE | | | | |
| Object | D1900V2 - SN: 5d060 | | | |
| Calibration Procedure(s) | TMC-XZ-01-027 Calibration procedure for dipole validation kits | | | |
| Calibration date: | July 15, 2009 | | | |
| Condition of the calibrated item | In Tolerance | | | |
| <p>This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.</p> <p>All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)℃ and humidity<70%.</p> <p>Calibration Equipment used (M&TE critical for calibration)</p> | | | | |
| Primary Standards | ID # | Cal Date(Calibrated by, Certificate No.) | | Scheduled Calibration |
| Power Meter NRVD | 101253 | 19-Jun-09 (TMC, No. JZ09-248) | | Jun-10 |
| Power sensor NRV-Z5 | 100333 | 19-Jun-09 (TMC, No. JZ09-248) | | Jun-10 |
| Reference Probe ES3DV3 | SN 3149 | 08-Dec-08(SPEAG, No.ES3-3149_Dec08) | | Dec-09 |
| DAE4 | SN 771 | 21-Nov-08(SPEAG, No.DAE4-771_Nov08) | | Nov-09 |
| RF generator E4438C | MY45092879 | 18-Jun-09(TMC, No.JZ09-302) | | Jun-10 |
| Network Analyzer 8753E | US38433212 | 03-Aug-08(TMC, No.JZ08-056) | | Aug-09 |
| Calibrated by: | Name Lin Hao | Function SAR Test Engineer | Signature  | |
| Reviewed by: | Qi Dianyuan | SAR Project Leader |  | |
| Approved by: | Lu Bingsong | Deputy Director of the laboratory |  | |
| Issued: July 15, 2009 | | | | |
| This calibration certificate shall not be reproduced except in full without written approval of the laboratory. | | | | |

Certificate No: D1900V2-5d060_Jul09

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Glossary:

| | |
|-------|--|
| TSL | tissue simulating liquid |
| ConvF | sensitivity in TSL / NORM _{x,y,z} |
| N/A | not applicable or not measured |

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

| | | |
|-------------------------------------|------------------------|-------------|
| DASY Version | DASY5 | V5.0 |
| Extrapolation | Advanced Extrapolation | |
| Phantom | 2mm Oval Phantom ELI4 | |
| Distance Dipole Center - TSL | 10 mm | with Spacer |
| Zoom Scan Resolution | dx, dy, dz = 5 mm | |
| Frequency | 1900 MHz \pm 1 MHz | |

Head TSL parameters

The following parameters and calculations were applied.

| | Temperature | Permittivity | Conductivity |
|---|---------------------|---------------------|---------------------|
| Nominal Head TSL parameters | 22.0 °C | 40.0 | 1.40 mho/m |
| Measured Head TSL parameters | (22.0 \pm 0.2) °C | 39.6 \pm 6 % | 1.40mho/m \pm 6 % |
| Head TSL temperature during test | (21.9 \pm 0.2) °C | ---- | ---- |

SAR result with Head TSL

| SAR averaged over 1 cm^3 (1 g) of Head TSL | Condition | |
|--|--------------------|---|
| SAR measured | 250 mW input power | 9.88 mW / g |
| SAR normalized | normalized to 1W | 39.5 mW / g |
| SAR for nominal Head TSL parameters ¹ | normalized to 1W | 37.8 mW /g \pm 17.0 % (k=2) |

| SAR averaged over 10 cm^3 (10 g) of Head TSL | Condition | |
|--|--------------------|---|
| SAR measured | 250 mW input power | 5.0 mW / g |
| SAR normalized | normalized to 1W | 20.0 mW / g |
| SAR for nominal Head TSL parameters ¹ | normalized to 1W | 19.8 mW /g \pm 16.5 % (k=2) |

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Body TSL parameters

The following parameters and calculations were applied.

| | Temperature | Permittivity | Conductivity |
|---|-----------------|--------------|------------------|
| Nominal Body TSL parameters | 22.0 °C | 53.3 | 1.52 mho/m |
| Measured Body TSL parameters | (22.0 ± 0.2) °C | 52.9 ± 6% | 1.55 mho/m ± 6 % |
| Body TSL temperature during test | (21.8 ± 0.2) °C | ---- | ---- |

SAR result with Body TSL

| SAR averaged over 1 cm^3 (1 g) of Body TSL | Condition | |
|--|--------------------|-----------------------------------|
| SAR measured | 250 mW input power | 10.2 mW / g |
| SAR normalized | normalized to 1W | 40.8 mW / g |
| SAR for nominal Body TSL parameters ² | normalized to 1W | 39.4 mW / g ± 17.0 % (k=2) |

| SAR averaged over 10 cm^3 (10 g) of Body TSL | Condition | |
|--|--------------------|-----------------------------------|
| SAR measured | 250 mW input power | 5.18 mW / g |
| SAR normalized | normalized to 1W | 20.72 mW / g |
| SAR for nominal Body TSL parameters ² | normalized to 1W | 21.0 mW / g ± 16.5 % (k=2) |

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Appendix

Antenna Parameters with Head TSL

| | |
|--------------------------------------|----------------------------|
| Impedance, transformed to feed point | $54.8\Omega + 4.0 j\Omega$ |
| Return Loss | - 23.7dB |

Antenna Parameters with Body TSL

| | |
|--------------------------------------|----------------------------|
| Impedance, transformed to feed point | $47.9\Omega + 7.1 j\Omega$ |
| Return Loss | - 22.6dB |

General Antenna Parameters and Design

| | |
|----------------------------------|----------|
| Electrical Delay (one direction) | 1.201 ns |
|----------------------------------|----------|

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

| | |
|-----------------|-------------------|
| Manufactured by | SPEAG |
| Manufactured on | December 10, 2004 |

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DASY5 Validation Report for Head TSL

Date/Time: 2009-7-15 14:15:30

Test Laboratory: TMC, Beijing, China

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: SN: 5d060

Communication System: CW Frequency: 1900 MHz Duty Cycle: 1:1

Medium: Head 1900MHz

Medium parameters used: $f = 1900 \text{ MHz}$; $\sigma = 1.40 \text{ mho/m}$; $\epsilon_r = 39.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(5.18, 5.18, 5.18); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=10mm/Zoom Scan (7x7x7)/Cube 0:

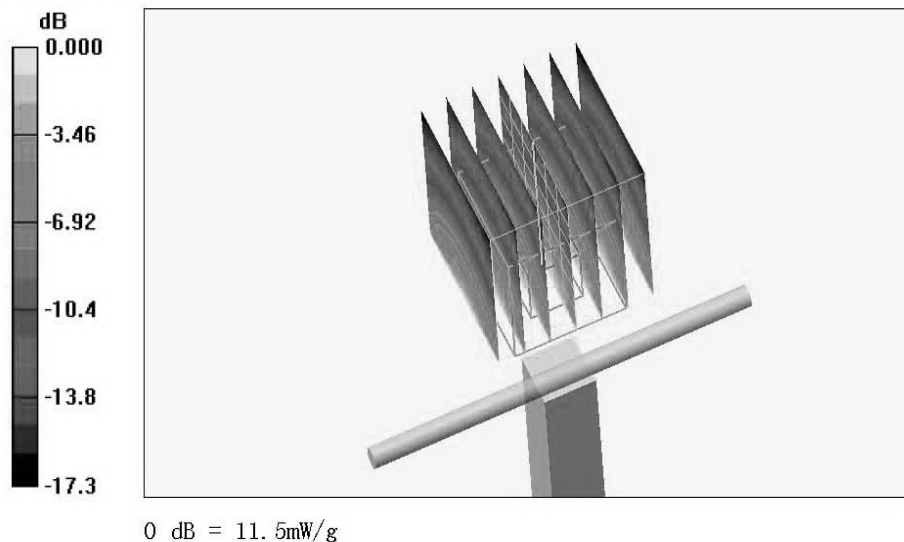
Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$

Reference Value = 85.1 V/m; Power Drift = -0.057 dB

Peak SAR (extrapolated) = 18.8 W/kg

SAR(1 g) = 9.88 mW/g; SAR(10 g) = 5.0 mW/g

Maximum value of SAR (measured) = 11.5 mW/g



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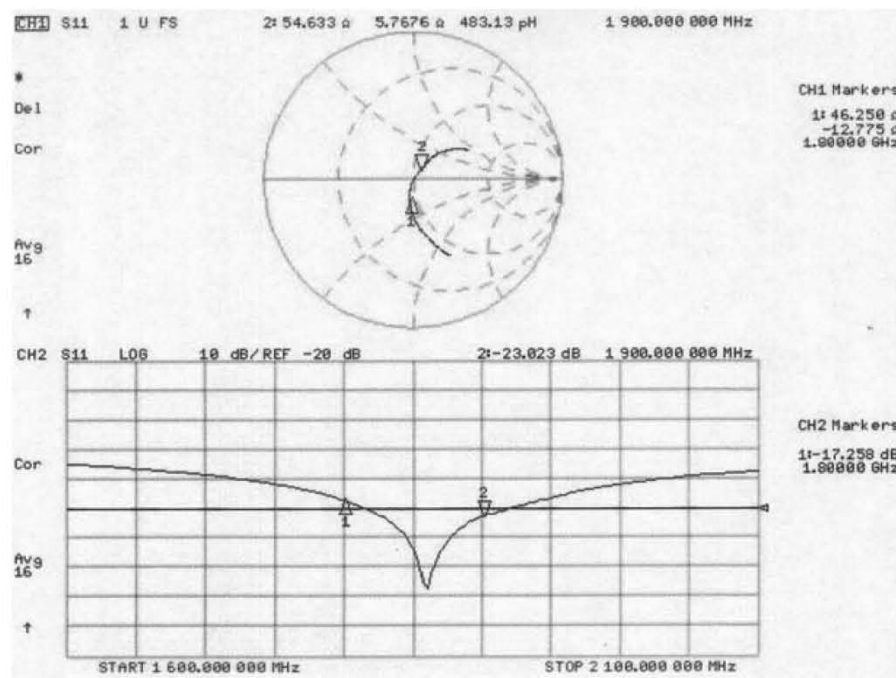
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Impedance Measurement Plot for Head TSL



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DASY5 Validation Report for Body TSL

Date/Time: 2009-7-15 15:37:31

Test Laboratory: TMC, Beijing, China

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: SN: 5d060

Communication System: CW Frequency: 1900 MHz Duty Cycle: 1:1

Medium: Body 1900MHz

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.55$ mho/m; $\epsilon_r = 52.9$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(4.97, 4.97, 4.97); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=10mm/Zoom Scan (7x7x7)/Cube 0:

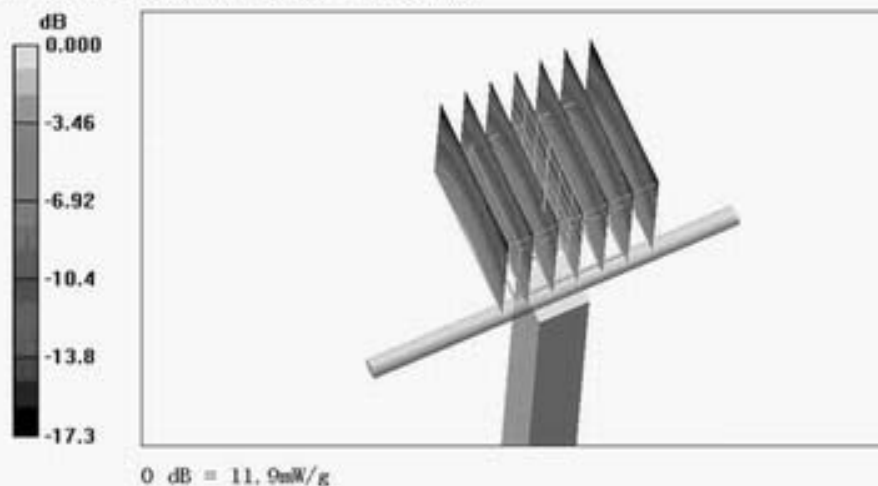
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 79.6 V/m; Power Drift = -0.009 dB

Peak SAR (extrapolated) = 19.1 W/kg

SAR(1 g) = 10.2 mW/g; SAR(10 g) = 5.18 mW/g

Maximum value of SAR (measured) = 11.9 mW/g



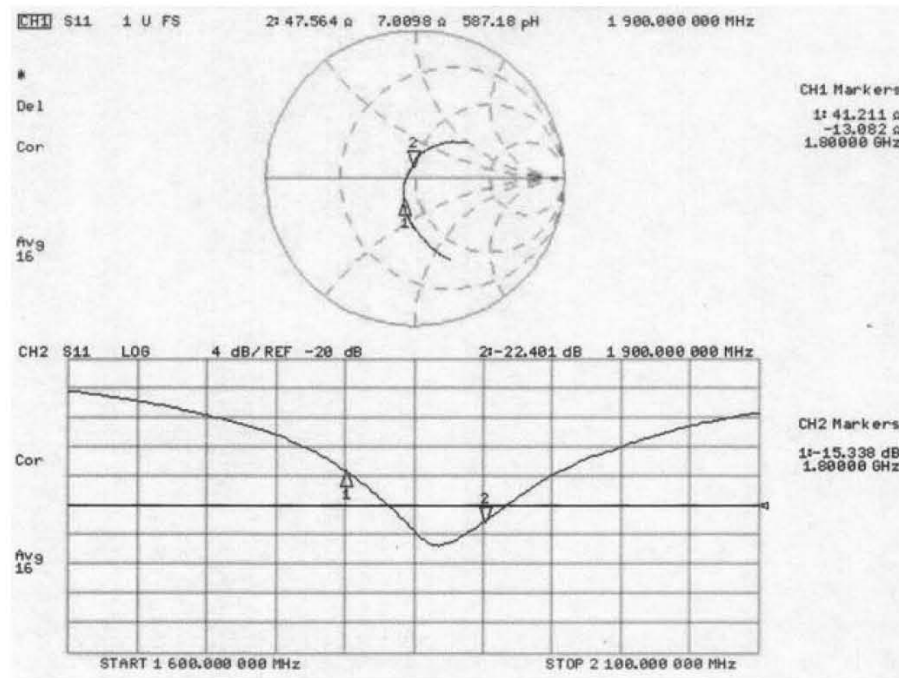
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Impedance Measurement Plot for Body TSL



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ANNEX G: DAE4 Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Auden**

Certificate No: **DAE4-452_Nov08**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BJ - SN: 452**

Calibration procedure(s) **QA CAL-06.v12**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **November 18, 2008**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|-----------------------------------|--------------------|----------------------------|------------------------|
| Fluke Process Calibrator Type 702 | SN: 6295803 | 30-Sep-08 (No: 7673) | Sep-09 |
| Keithley Multimeter Type 2001 | SN: 0810278 | 30-Sep-08 (No: 7670) | Sep-09 |
| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
| Calibrator Box V1.1 | SE UMS 006 AB 1004 | 06-Jun-08 (in house check) | In house check: Jun-09 |

Calibrated by:

| Name | Function | Signature |
|-------------------|------------|-----------|
| Dominique Steffen | Technician | |

Approved by:

| | |
|-------------|--------------|
| Fin Bomholt | R&D Director |
|-------------|--------------|

Issued: November 18, 2008

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: DAE4-452_Nov08

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**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| Calibration Factors | X | Y | Z |
|---------------------|--------------------------|--------------------------|--------------------------|
| High Range | 404.585 \pm 0.1% (k=2) | 404.416 \pm 0.1% (k=2) | 404.565 \pm 0.1% (k=2) |
| Low Range | 3.97854 \pm 0.7% (k=2) | 3.95135 \pm 0.7% (k=2) | 3.98063 \pm 0.7% (k=2) |

Connector Angle

| | |
|---|-----------------|
| Connector Angle to be used in DASY system | 148 ° \pm 1 ° |
|---|-----------------|

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Appendix

1. DC Voltage Linearity

| High Range | Input (μV) | Reading (μV) | Error (%) |
|-------------------|-------------------------|---------------------------|-----------|
| Channel X + Input | 200000 | 200000 | 0.00 |
| Channel X + Input | 20000 | 20006.89 | 0.03 |
| Channel X - Input | 20000 | -20003.71 | 0.02 |
| Channel Y + Input | 200000 | 200000.5 | 0.00 |
| Channel Y + Input | 20000 | 20008.05 | 0.04 |
| Channel Y - Input | 20000 | -20006.61 | 0.03 |
| Channel Z + Input | 200000 | 199999.6 | 0.00 |
| Channel Z + Input | 20000 | 20006.84 | 0.03 |
| Channel Z - Input | 20000 | -20004.66 | 0.02 |

| Low Range | Input (μV) | Reading (μV) | Error (%) |
|-------------------|-------------------------|---------------------------|-----------|
| Channel X + Input | 2000 | 2000 | 0.00 |
| Channel X + Input | 200 | 200.19 | 0.09 |
| Channel X - Input | 200 | -199.99 | 0.00 |
| Channel Y + Input | 2000 | 2000 | 0.00 |
| Channel Y + Input | 200 | 199.38 | -0.31 |
| Channel Y - Input | 200 | -200.73 | 0.36 |
| Channel Z + Input | 2000 | 2000.1 | 0.00 |
| Channel Z + Input | 200 | 199.25 | -0.38 |
| Channel Z - Input | 200 | -201.52 | 0.76 |

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Common mode Input Voltage (mV) | High Range Average Reading (μV) | Low Range Average Reading (μV) |
|-----------|--------------------------------|--|---|
| Channel X | 200 | 2.99 | 1.90 |
| | - 200 | -1.54 | -1.85 |
| Channel Y | 200 | -8.82 | -8.73 |
| | - 200 | 6.90 | 6.96 |
| Channel Z | 200 | 9.94 | 10.21 |
| | - 200 | -13.53 | -13.21 |

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Input Voltage (mV) | Channel X (μV) | Channel Y (μV) | Channel Z (μV) |
|-----------|--------------------|-----------------------------|-----------------------------|-----------------------------|
| Channel X | 200 | - | 1.31 | -0.98 |
| Channel Y | 200 | 1.52 | - | 2.97 |
| Channel Z | 200 | -1.16 | 0.18 | - |

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | High Range (LSB) | Low Range (LSB) |
|-----------|------------------|-----------------|
| Channel X | 16123 | 16646 |
| Channel Y | 15886 | 16452 |
| Channel Z | 16175 | 16346 |

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

| | Average (μ V) | min. Offset (μ V) | max. Offset (μ V) | Std. Deviation (μ V) |
|-----------|--------------------|------------------------|------------------------|---------------------------|
| Channel X | 0.53 | -0.80 | 1.64 | 0.33 |
| Channel Y | -1.51 | -2.67 | -0.89 | 0.35 |
| Channel Z | -1.99 | -3.07 | -1.43 | 0.29 |

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

| | Zeroing (MOhm) | Measuring (MOhm) |
|-----------|----------------|------------------|
| Channel X | 0.1999 | 198.3 |
| Channel Y | 0.1999 | 200.1 |
| Channel Z | 0.1999 | 199.3 |

8. Low Battery Alarm Voltage (verified during pre test)

| Typical values | Alarm Level (VDC) |
|----------------|-------------------|
| Supply (+ Vcc) | +7.9 |
| Supply (- Vcc) | -7.6 |

9. Power Consumption (verified during pre test)

| Typical values | Switched off (mA) | Stand by (mA) | Transmitting (mA) |
|----------------|-------------------|---------------|-------------------|
| Supply (+ Vcc) | +0.0 | +6 | +14 |
| Supply (- Vcc) | -0.01 | -8 | -9 |

ANNEX H: The EUT Appearances and Test Configuration



Picture 6: Constituents of EUT



Picture 7: Left Hand Touch Cheek Position



Picture 8: Left Hand Tilt 15 Degree Position



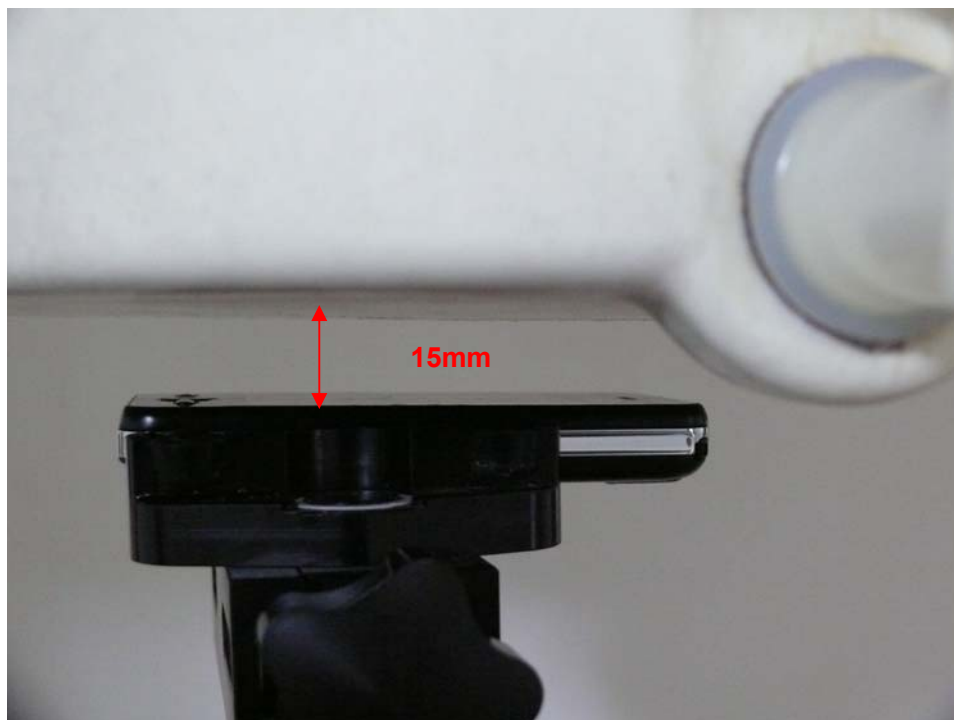
Picture 9: Right Hand Touch Cheek Position



Picture 10: Right Hand Tilt 15 Degree Position



Picture 11: Body, The EUT display towards ground, the distance from handset to the bottom of the Phantom is 15mm



Picture 12: Body, The EUT display towards phantom, the distance from handset to the bottom of the Phantom is 15mm